## MOSFET – Power, Single, N-Channel, μ8FL 30 V, 52 A

## Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## Applications

- Low-Side DC-DC Converters
- Power Load Switch
- Notebook Battery Management
- Motor Control

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V <sub>DSS</sub>	30	V		
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	14.3	А
Current $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 85°C	1	10.3	1
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	P <sub>D</sub>	2.21	W
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	20.3	А
Current R <sub>θJA</sub> ≤ 10 s (Note 1)		T <sub>A</sub> = 85°C		14.7	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	$T_A = 25^{\circ}C$	P <sub>D</sub>	4.48	W
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	8.9	А
Current $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 85°C	1	6.4	1
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	0.85	W
Continuous Drain		T <sub>C</sub> = 25°C	Ι <sub>D</sub>	52	А
Current $R_{\theta JC}$ (Note 1)		$T_C = 85^{\circ}C$		38	
Power Dissipation $R_{\theta JC}$ (Note 1)		$T_C = 25^{\circ}C$	PD	29.8	W
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	170	А
Operating Junction and S	Т <sub>Ј</sub> , T <sub>stg</sub>	–55 to +150	°C		
Source Current (Body Die	ا <sub>S</sub>	35	А		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
$ \begin{array}{l} \mbox{Single Pulse Drain-to-So} \\ (T_J = 25^\circ C,  V_{DD} = 50 \mbox{ V},  V_{L} \\ I_L = 31 \mbox{ A}_{pk},  L = 0.1 \mbox{ mH},  F \end{array} $	E <sub>AS</sub>	48	mJ		
Lead Temperature for So (1/8" from case for 10 s)	dering Pur	poses	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

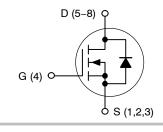


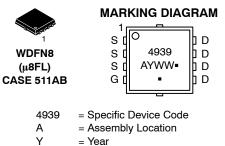
## **ON Semiconductor®**

## http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
30 V	5.5 mΩ @ 10 V	52 A	
	8.0 mΩ @ 4.5 V	52 A	

## **N-Channel MOSFET**





(Note: Microdot may be in either location)

= Work Week = Pb-Free Package

WW

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTTFS4939NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4939NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
  Surface-mounted on FR4 board using the minimum recommended pad size.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ extsf{ heta}JC}$	4.2	°C/W
Junction-to-Ambient - Steady State (Note 3)	R <sub>θJA</sub>	56.5	
Junction-to-Ambient – Steady State (Note 4)	R <sub>θJA</sub>	146.5	
Junction-to-Ambient – (t $\leq$ 10 s) (Note 3)	R <sub>0JA</sub>	28	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size (40 mm<sup>2</sup>, 1 oz. Cu).

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Conditi	ion	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$				15		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 24 V$	$T_J = 125^{\circ}C$			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ±20 V				±100	nA

## **ON CHARACTERISTICS** (Note 5)

Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 2$	250 μA	1.2		2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	n) V <sub>GS</sub> = 10 V	I <sub>D</sub> = 20 A		4.1	5.5	mΩ
			I <sub>D</sub> = 10 A		4.1		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 20 A		6.0	8.0	1
			l <sub>D</sub> = 10 A		5.9		
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			35		S

## CHARGES AND CAPACITANCES

C <sub>iss</sub>			1979		pF
C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 15 V		711		
C <sub>rss</sub>	1		20.2		
Q <sub>G(TOT)</sub>			12.4		nC
Q <sub>G(TH)</sub>			3.2		
Q <sub>GS</sub>	$v_{GS} = 4.5 \text{ V}, v_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$		6.0		
Q <sub>GD</sub>	1		1.8		
Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 20 A		28		nC
	Coss        Crss        QG(TOT)        QG(TH)        QGS        QGD	$\begin{tabular}{ c c c c c c } \hline $C_{oss}$ & $V_{GS} = 0 $V, $f = 1.0 $MHz, $V_{DS} = 15 $V$ \\ \hline $C_{rss}$ & $Q_{G(TOT)}$ \\ \hline $Q_{G(TOT)}$ & $V_{GS} = 4.5 $V, $V_{DS} = 15 $V, $I_{D} = 20 $A$ \\ \hline $Q_{GD}$ & $Q_{GD}$ & $V_{GS} = 4.5 $V, $V_{DS} = 15 $V, $I_{D} = 20 $A$ \\ \hline $Q_{GD}$ & $V_{GS} = 4.5 $V, $V_{DS} = 15 $V, $I_{D} = 20 $A$ \\ \hline $Q_{GD}$ & $V_{GS} = 4.5 $V, $V_{DS} = 15 $V, $I_{D} = 20 $A$ \\ \hline $Q_{GD}$ & $V_{GS} = 4.5 $V, $V_{DS} = 15 $V, $I_{D} = 20 $A$ \\ \hline $Q_{GD}$ & $V_{GS} = 4.5 $V, $V_{DS} = 15 $V, $I_{D} = 20 $A$ \\ \hline $Q_{GD}$ & $V_{GS} = 4.5 $V, $V_{DS} = 15 $V, $V_{DS} = 20 $A$ \\ \hline $Q_{GD}$ & $V_{SS} = 15 $V, $$	$\begin{tabular}{ c c c c c c } \hline $C_{oss}$ & $V_{GS} = 0 $ V, $f = 1.0 $ MHz, $V_{DS} = 15 $ V$ & $$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$	$\begin{tabular}{ c c c c c c } \hline $V_{GS}$ & $V_{GS}$ = 0 V, f = 1.0 MHz, $V_{DS}$ = 15 V & $711$ \\ \hline $C_{rss}$ & $20.2$ \\ \hline $Q_{G(TOT)}$ & $12.4$ \\ \hline $Q_{G(TH)}$ & $V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 20 A & $3.2$ \\ \hline $Q_{GD}$ & $1.8$ \\ \hline \end{tabular}$	$\begin{tabular}{ c c c c c c } \hline $V_{GS}$ & $V_{GS}$ = 0 V, f = 1.0 MHz, $V_{DS}$ = 15 V & $711$ & $20.2$ & $$

## SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	t <sub>d(on)</sub>		12.2	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	20.6	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{\rm D}$ = 15 A, R <sub>G</sub> = 3.0 $\Omega$	20.8	
Fall Time	t <sub>f</sub>		3.9	

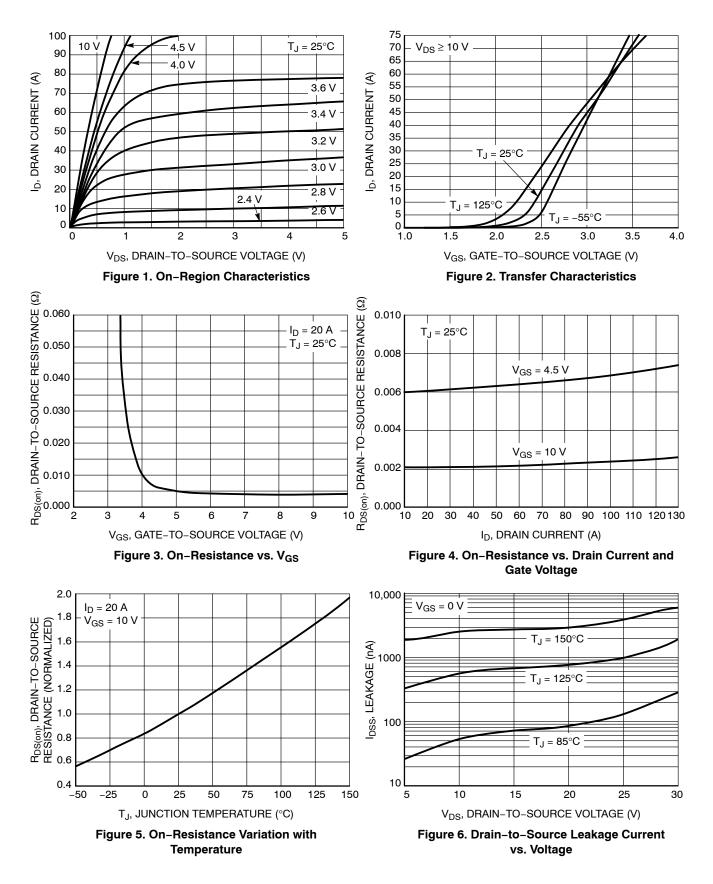
5. Pulse Test: pulse width = 300  $\mu s,$  duty cycle  $\leq$  2%.

6. Switching characteristics are independent of operating junction temperatures.

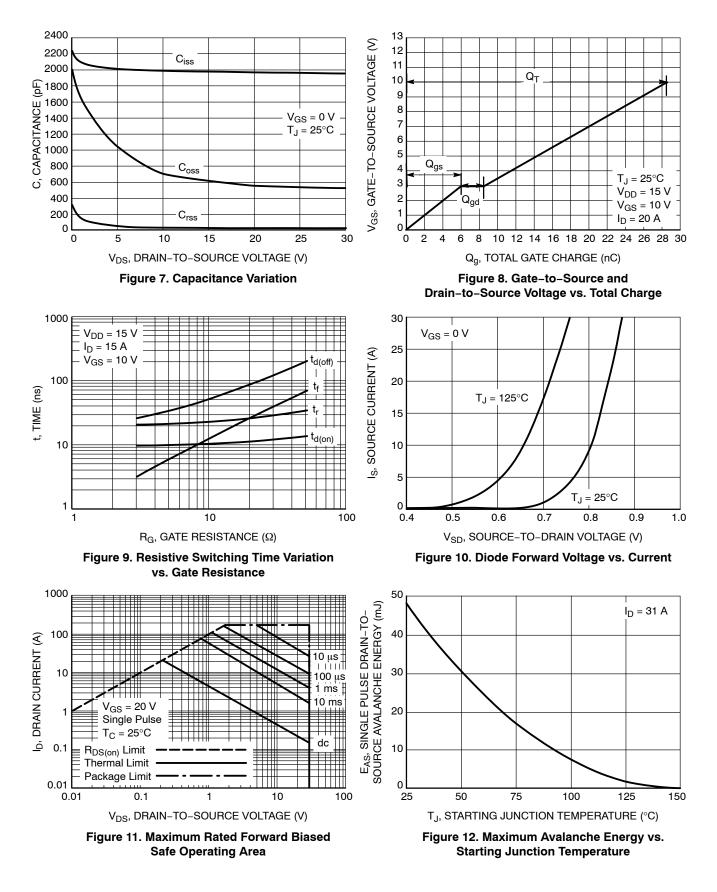
## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Uni
SWITCHING CHARACTERISTIC	<b>S</b> (Note 6)				•		•
Turn-On Delay Time	t <sub>d(on)</sub>				8.7		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>C</sub>	<sub>0S</sub> = 15 V,		19.5		
Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> = 10 V, V <sub>E</sub> I <sub>D</sub> = 15 A, R <sub>G</sub>	= 3.0 Ω		25.3		
Fall Time	t <sub>f</sub>				3.2		
DRAIN-SOURCE DIODE CHARA	ACTERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$ $T_{J} = 25$	$T_J = 25^{\circ}C$		0.84	1.2	V
		$I_{\rm S} = 20  \rm A$	T <sub>J</sub> = 125°C		0.71		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, d <sub>IS</sub> /d <sub>t</sub> = 100 A/µs, I <sub>S</sub> = 20 A			35.5		ns
Charge Time	t <sub>a</sub>				19		1
Discharge Time	t <sub>b</sub>				16.5		1
Reverse Recovery Charge	Q <sub>RR</sub>				28		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				0.38		nH
Drain Inductance	L <sub>D</sub>	т ог			0.054		1
Gate Inductance	L <sub>G</sub>	T <sub>A</sub> = 25°C			1.3		1
Gate Resistance	R <sub>G</sub>				1.1	2.0	Ω

## **TYPICAL CHARACTERISTICS**



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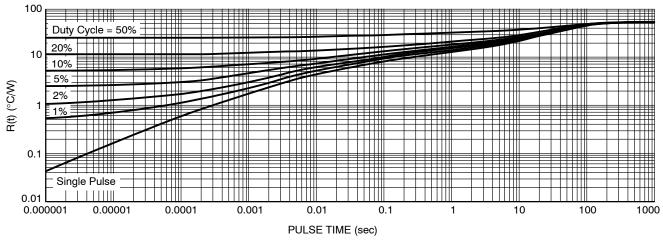
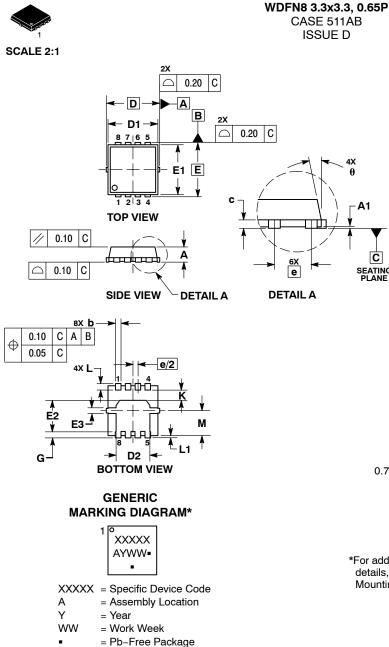


Figure 13. Thermal Response

# DURSEM

DATE 23 APR 2012



\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

NOTES:

**A1** 

C

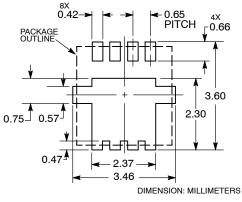
SEATING PLANE

LES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 1. 2.

- 3.

	MI	LLIMETE	RS	INCHES					
DIM	MIN	NOM	MAX	MIN	NOM	MAX			
Α	0.70	0.75	0.80	0.028	0.030	0.031			
A1	0.00		0.05	0.000		0.002			
b	0.23	0.30	0.40	0.009	0.012	0.016			
с	0.15	0.20	0.25	0.006	0.008	0.010			
D		3.30 BSC		0	.130 BSC	)			
D1	2.95	3.05	3.15	0.116	0.120	0.124			
D2	1.98	2.11	2.24	0.078	0.083	0.088			
E		3.30 BSC		0.130 BSC					
E1	2.95	3.05	3.15	0.116	0.120	0.124			
E2	1.47	1.60	1.73	0.058	0.063	0.068			
E3	0.23	0.30	0.40	0.009	0.012	0.016			
е		0.65 BSC	;	0.026 BSC					
G	0.30	0.41	0.51	0.012	0.016	0.020			
к	0.65	0.80	0.95	0.026	0.032	0.037			
L	0.30	0.43	0.56	0.012	0.017	0.022			
L1	0.06	0.13	0.20	0.002	0.005	0.008			
М	1.40	1.50	1.60	0.055	0.059	0.063			
θ	0 °		12 °	0 °		12 °			

**SOLDERING FOOTPRINT\*** 



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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